Application/Control No. Applicant(s)/Patent Under Reexamination 10/700,311 TAKAHASHI ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 **HELEN SHIBRU** 2621 **U.S. PATENT DOCUMENTS Document Number** Date Classification Name MM-YYYY Country Code-Number-Kind Code * Takeshi, Kindaichi 348/211.99 US-2007/0109420 05-2007 Α 358/1.15 US-2002/0113992 08-2002 Takakura et al. В 709/229 С US-2002/0194351 12-2002 Nishimura et al. US-D US-Ε US-F US-G US-Н USı US-J

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